

October 1987 Revised January 1999

CD4538BC Dual Precision Monostable

General Description

The CD4538BC is a dual, precision monostable multivibrator with independent trigger and reset controls. The device is retriggerable and resettable, and the control inputs are internally latched. Two trigger inputs are provided to allow either rising or falling edge triggering. The reset inputs are active LOW and prevent triggering while active. Precise control of output pulse-width has been achieved using linear CMOS techniques. The pulse duration and accuracy are determined by external components R_X and $\mathsf{C}_\mathsf{X}.$ The device does not allow the timing capacitor to discharge through the timing pin on power-down condition. For this reason, no external protection resistor is required in series with the timing pin. Input protection from static discharge is provided on all pins.

Features

■ Wide supply voltage range: 3.0V to 15V

■ High noise immunity: 0.45 V_{CC} (typ.)

■ Low power TTL compatibility: Fan out of 2 driving 74L or 1 driving 74LS

■ New formula: PW_{OUT} = RC (PW in seconds, R in Ohms, C in Farads)

■ ±1.0% pulse-width variation from part to part (typ.)

■ Wide pulse-width range: 1 µs to ∞

■ Separate latched reset inputs

■ Symmetrical output sink and source capability

■ Low standby current: 5 nA (typ.) @ 5 V_{DC}

■ Pin compatible to CD4528BC

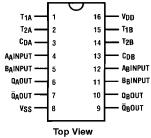
Ordering Code:

ľ	Order Number	Package Number	Package Description
		M16A	16-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-012, 0.150" Narrow Body
		M16B	16-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-013, 0.300" Wide Body
ľ	CD4538BCN	N16E	16-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300" Wide

Devices also available in Tape and Reel. Specify by appending the suffix letter "X" to the ordering code

Connection Diagram

Pin Assignments for DIP and SOIC



Truth Table

	Ir	puts	Outputs			
С	lear	Α	B Q		Q	
	L	Х	Х	L	Н	
	Χ	Н	Х	L	Н	
	Χ	x	L	L	Н	
	Н	L	↓	~	ъ	
	Н	1	н	~	ъ	

H = HIGH Level

L = LOW Level

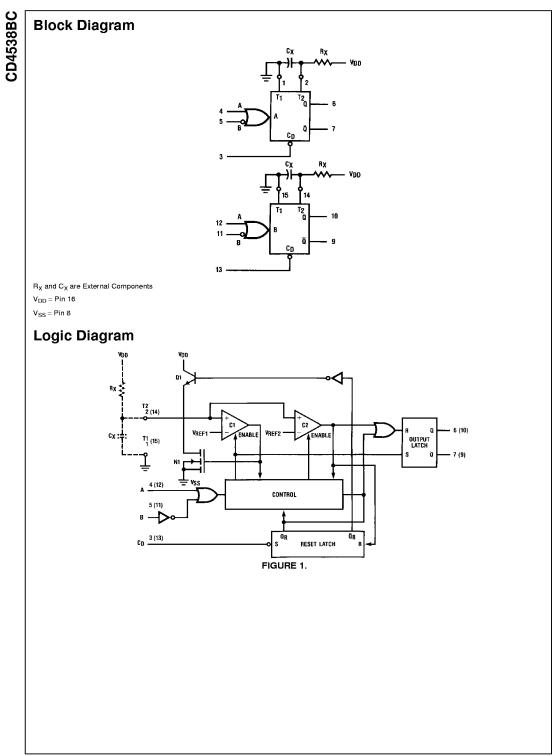
= Transition from LOW-to-HIGH

↓ = Transition from HIGH-to-LOW

__ = One HIGH Level Pulse __ = One LOW Level Pulse

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Theory of Operation

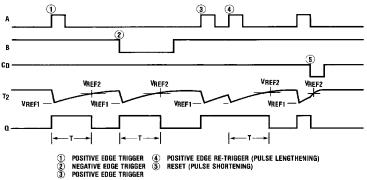


FIGURE 2.

Trigger Operation

The block diagram of the CD4538BC is shown in Figure 1, with circuit operation following.

As shown in Figure 1 and Figure 2, before an input trigger occurs, the monostable is in the quiescent state with the Q output low, and the timing capacitor CX completely charged to V_{DD} . When the trigger input A goes from V_{SS} to V_{DD} (while inputs B and C_D are held to V_{DD}) a valid trigger is recognized, which turns on comparator C1 and N-Channel transistor N1⁽¹⁾. At the same time the output latch is set. With transistor N1 on, the capacitor C_X rapidly discharges toward VSS until VBEE1 is reached. At this point the output of comparator C1 changes state and transistor N1 turns off. Comparator C1 then turns off while at the same time comparator C2 turns on. With transistor N1 off, the capacitor Cx begins to charge through the timing resistor, R_X , toward V_{DD}. When the voltage across C_X equals V_{REF2}, comparator C2 changes state causing the output latch to reset (Q goes low) while at the same time disabling comparator C2. This ends the timing cycle with the monostable in the quiescent state, waiting for the next trigger.

A valid trigger is also recognized when trigger input B goes from V_{DD} to V_{SS} (while input A is at V_{SS} and input C_D is at V_{DD})⁽²⁾.

It should be noted that in the quiescent state C_X is fully charged to V_{DD} , causing the current through resistor R_X to be zero. Both comparators are "off" with the total device current due only to reverse junction leakages. An added feature of the CD4538BC is that the output latch is set via the input trigger without regard to the capacitor voltage.

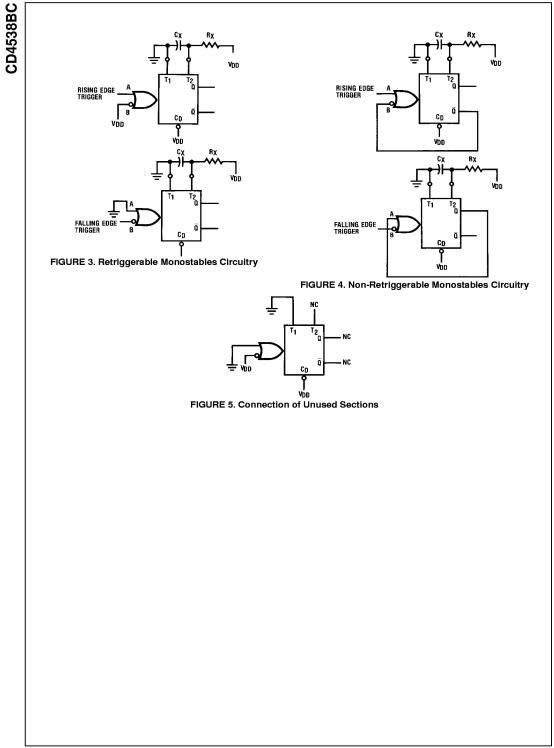
Thus, propagation delay from trigger to Q is independent of the value of $C_X,\ R_X,$ or the duty cycle of the input waveform.

Retrigger Operation

The CD4538BC is retriggered if a valid trigger occurs ⁽³⁾ followed by another valid trigger ⁽⁴⁾ before the Q output has returned to the quiescent (zero) state. Any retrigger, after the timing node voltage at pin 2 or 14 has begun to rise from V_{REF1} , but has not yet reached V_{REF2} , will cause an increase in output pulse width T. When a valid retrigger is initiated ⁽⁴⁾, the voltage at T2 will again drop to V_{REF1} before progressing along the RC charging curve toward V_{DD} . The Q output will remain high until time T, after the last valid retrigger.

Reset Operation

The CD4538BC may be reset during the generation of the output pulse. In the reset mode of operation, an input pulse on C_D sets the reset latch and causes the capacitor to be fast charged to V_{DD} by turning on transistor $Q1^{(5)}.$ When the voltage on the capacitor reaches $V_{REF2},$ the reset latch will clear and then be ready to accept another pulse. If the C_D input is held low, any trigger inputs that occur will be inhibited and the Q and \overline{Q} outputs of the output latch will not change. Since the Q output is reset when an input low level is detected on the C_D input, the output pulse T can be made significantly shorter than the minimum pulse width specification.



Absolute Maximum Ratings(Note 1)

(Note 2)

DC Supply Voltage (V_{DD}) $-0.5 \text{ to } +18 \text{ V}_{DC}$ Input Voltage (V_{IN}) $-0.5 \text{ to } V_{DD} + 0.5 \text{ V}_{DC}$ Storage Temperature Range (T_S) $-65^{\circ}\text{C to } +150^{\circ}\text{C}$

Power Dissipation (P_D)

Dual-In-Line700 mWSmall Outline500 mW

Lead Temperature (T_L)

(Soldering, 10 seconds) 260°C

Recommended Operating Conditions (Note 2)

DC Supply Voltage (V_{DD}) 3 to 15 V_{DC} Input Voltage (V_{IN}) 0 to V_{DD} V_{DC}

Operating Temperature Range (T_A) -40°C to +85°C

Note 1: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed, they are not meant to imply that the devices should be operated at these limits. The tables of "Recommended Operating Conditions" and "Electrical Characteristics" provide conditions for actual device operation.

Note 2: $V_{SS} = \text{0V}$ unless otherwise specified.

DC Electrical Characteristics (Note 2)

ol Parameter	Conditions	–40°C		+25°C		+85°C		Units	
	Conditions	Min	Max	Min	Тур	Max	Min	Max	Oille
Quiescent	$V_{DD} = 5V$ $V_{IH} = V_{DD}$		20		0.005	20		150	μА
Device Current	$V_{DD} = 10V$ $V_{IL} = V_{SS}$		40		0.010	40		300	μΑ
	V _{DD} = 15V All Outputs Open		80		0.015	80		600	μΑ
LOW Level	$V_{DD} = 5V$ $ I_O < 1 \mu A$		0.05		0	0.05		0.05	٧
Output Voltage	$V_{DD} = 10V$ $V_{IH} = V_{DD}$, $V_{IL} = V_{SS}$		0.05		0	0.05		0.05	V
	V _{DD} = 15V		0.05		0	0.05		0.05	V
HIGH Level	$V_{DD} = 5V$ $ I_O < 1 \mu A$	4.95		4.95	5		4.95		٧
Output Voltage	$V_{DD} = 10V$ $V_{IH} = V_{DD}$, $V_{IL} = V_{SS}$	9.95		9.95	10		9.95		V
	V _{DD} = 15V	14.95		14.95	15		14.95		V
LOW Level	l _O < 1 μA								
Input Voltage	V _{DD} = 5V, V _O = 0.5V or 4.5V		1.5		2.25	1.5		1.5	V
	V _{DD} = 10V, V _O = 1.0V or 9.0V		3.0		4.50	3.0		3.0	V
	V _{DD} = 15V, V _O = 1.5V or 13.5V		4.0		6.75	4.0		4.0	V
HIGH Level	l _O < 1 μA								
Input Voltage	V _{DD} = 5V, V _O = 0.5V or 4.5V	3.5		3.5	2.75		3.5		V
	V _{DD} = 10V, V _O = 1.0V or 9.0V	7.0		7.0	5.50		7.0		٧
	V _{DD} = 15V, V _O = 1.5V or 13.5V	11.0		11.0	8.25		11.0		V
LOW Level	$V_{DD} = 5V$, $V_{O} = 0.4V$ $V_{IH} = V_{DD}$	0.52		0.44	0.88		0.36		mA
Output Current	$V_{DD} = 10V, V_{O} = 0.5V V_{IL} = V_{SS}$	1.3		1.1	2.25		0.9		mA
(Note 3)	V _D = 15V, V _O = 1.5V	3.6		3.0	8.8		2.4		mA
HIGH Level	$V_{DD} = 5V, V_{O} = 4.6V$	-0.52		-0.44	-0.88		-0.36		mA
Output Current	$V_{DD} = 10V, V_{O} = 9.5V V_{IL} = V_{SS}$	-1.3		-1.1	-2.25		-0.9		mA
(Note 3)	V _D = 15V, V _O = 13.5V	-3.6		-3.0	-8.8		-2.4		mA
Input Current,	V _{DD} = 15V, V _{IN} = 0V or 15V		±0.02		±10 ⁻⁵	±0.05		±0.5	μА
Pin 2 or 14								150 300 600 0.05 0.05 0.05 1.5 3.0 4.0	
Input Current	V _{DD} = 15V, V _{IN} = 0V or 15V		±0.3		±10 ⁻⁵	±0.3		±1.0	μА
Other Inputs									
	Quiescent Device Current LOW Level Output Voltage HIGH Level Output Voltage LOW Level Input Voltage HIGH Level Input Voltage LOW Level Input Voltage HIGH Level Output Current (Note 3) HIGH Level Output Current (Note 3) Input Current, Pin 2 or 14 Input Current	$\begin{array}{c ccccccccccccccccccccccccccccccccccc$	Parameter Conditions Min	Parameter Conditions Min Max	Parameter Conditions Min Max Min Max Min Max Min Min	Parameter Conditions Min Max Min Typ	Parameter Conditions Min Max Min Typ Max Quiescent V _{DD} = 5V V _{IH} = V _{DD} 20 0.005 20 Device Current V _{DD} = 10V V _{IL} = V _{SS} 40 0.010 40 LOW Level V _{DD} = 5V I o < 1 μA	Parameter Conditions Min Max Min Typ Max Min Min Quiescent V _{DD} = 5V V _{IH} = V _{DD} V _{IL} = V _{SS} 40 0.005 20 0.005 80 0.015 0.015 80 0.015 0.01	Parameter Conditions Min Max Min Typ Max Min Ma

Note 3: I_{OH} and I_{OL} are tested one output at a time.

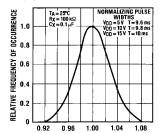
AC Electrical Characteristics (Note 4) $T_A = 25^{\circ}C$, $C_L = 50$ pF, and $t_r = t_f = 20$ ns unless otherwise specified

Symbol	Parameter	Cor	nditions	Min	Тур	Max	Units
t _{TLH} , t _{THL}	Output Transition Time	$V_{DD} = 5V$			100	200	ns
		V _{DD} = 10V			50	100	ns
		$V_{DD} = 15V$			40	80	ns
t _{PLH} , t _{PHL}	Propagation Delay Time	Trigger Operation—					
		A or B to Q or Q					
		$V_{DD} = 5V$			300	600	ns
		$V_{DD} = 10V$			150	300	ns
		V _{DD} = 15V			100	220	ns
		Reset Operation—					
		C _D to Q or Q					
		$V_{DD} = 5V$			250	500	ns
		V _{DD} = 10V			125	250	ns
		V _{DD} = 15V			95	190	ns
t _{WL} , t _{WH}	Minimum Input Pulse Width	V _{DD} = 5V			35	70	ns
	A, B, or C _D	V _{DD} = 10V			30	60	ns
		V _{DD} = 15V			25	50	ns
t _{BB}	Minimum Retrigger Time	V _{DD} = 5V				0	ns
		V _{DD} = 10V			0	0	ns
		V _{DD} = 15V				0	ns
C _{IN}	Input Capacitance	Pin 2 or 14			10		pF
		Other Inputs			5	7.5	рF
P W OUT	Output Pulse Width (Q or Q)	$R_X = 100 \text{ k}\Omega$	$V_{DD} = 5V$	208	226	244	μs
	(Note: For Typical Distribution,	$C_X = 0.002 \mu F$	$V_{DD} = 10V$	211	230	248	μs
	see Figure 6)		V _{DD} = 15V	216	235	254	μs
		$R_X = 100 \text{ k}\Omega$	V _{DD} = 5V	8.83	9.60	10.37	ms
		$C_X = 0.1 \ \mu F$	$V_{DD} = 10V$	9.02	9.80	10.59	ms
			V _{DD} = 15V	9.20	10.00	10.80	ms
		$R_X = 100 \text{ k}\Omega$	V _{DD} = 5V	0.87	0.95	1.03	s
		$C_X = 10.0 \mu F$	$V_{DD} = 10V$	0.89	0.97	1.05	s
			$V_{DD} = 15V$	0.91	0.99	1.07	s
Pulse Width Ma	atch between	$R_X = 100 \text{ k}\Omega$	$V_{DD} = 5V$		±1		%
Circuits in the S	Same Package	$C_X = 0.1 \ \mu F$	$V_{DD} = 10V$		±1		%
$C_X = 0.1 \; \mu F, \; R_X$	$z = 100 \text{ k}\Omega$		$V_{DD} = 15V$		±1		%
Operating Con	ditions	-					
R _X	External Timing Resistance			5.0		(Note 5)	kΩ
c_{x}	External Timing Capacitance			0		No Limit	рF

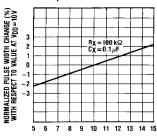
Note 4: AC parameters are guaranteed by DC correlated testing.

Note 5: The maximum usable resistance R_X is a function of the leakage of the Capacitor C_X, leakage of the CD4538BC, and leakage due to board layout, surface resistance, etc.

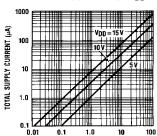
Typical Applications



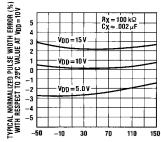
OUTPUT PULSE WIDTH
(NORMALIZED TO MEAN VALUE FOR EACH VDD)
FIGURE 6. Typical Normalized Distribution of Units
for Output Pulse Width



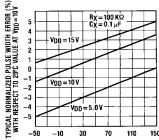
 $\label{eq:VDD} $$ V_{DD}$, SUPPLY VOLTAGE (VOLTS)$ FIGURE 7. Typical Pulse Width Variation as a Function of Supply Voltage V_{DD} $$$



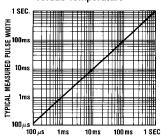
OUTPUT DUTY CYCLE (%) FIGURE 8. Typical Total Supply Current Versus Output Duty Cycle, $R_X=100~k\Omega,~C_L=50~pF,~C_X=100~pF,~One~Monostable~Switching~Only$



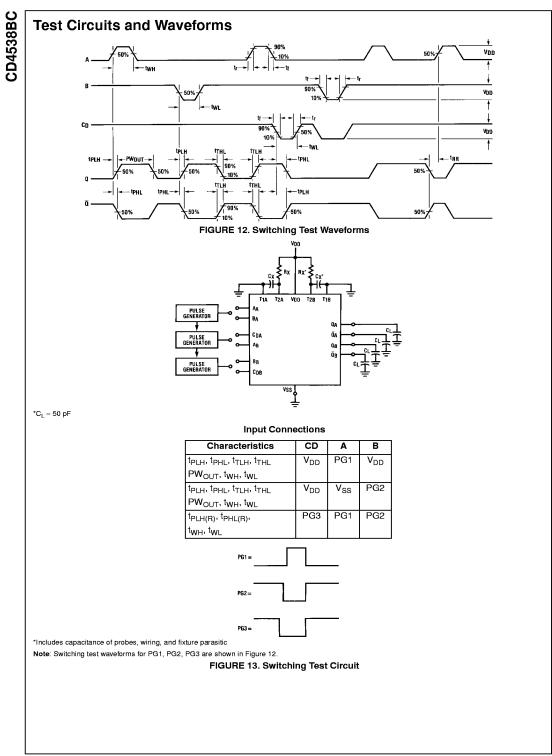
T_A, AMBIENT TEMPERATURE (°C)
FIGURE 9. Typical Pulse Width Error
Versus Temperature

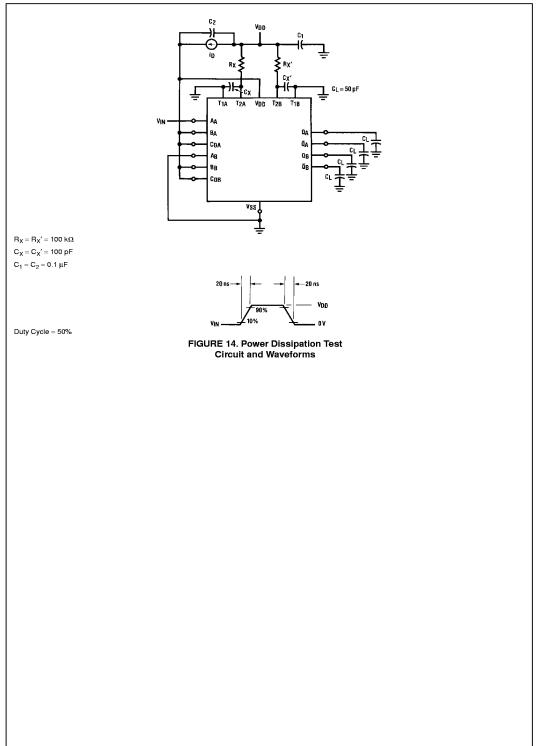


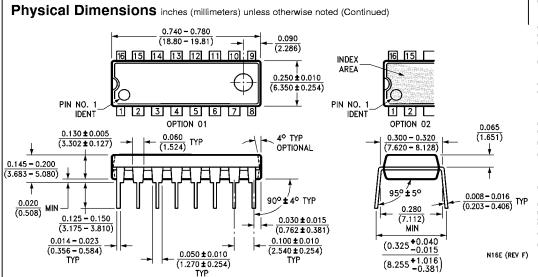
TA, AMBIENT TEMPERATURE (°C)
FIGURE 10. Typical Pulse Width Error
Versus Temperature



TIMING RC PRODUCT
FIGURE 11. Typical Pulse Width Versus
Timing RC Product







16-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300" Wide Package Number N16E

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